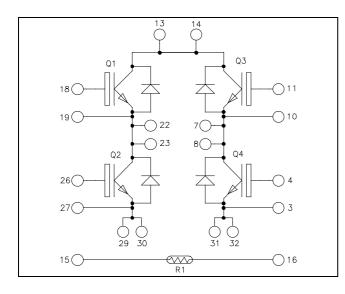
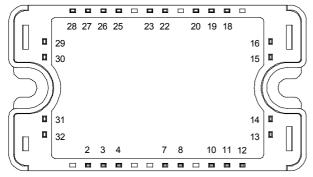


APTGF50H60T3G

Full - Bridge NPT IGBT Power Module





All multiple inputs and outputs must be shorted together Example: 13/14 ; 29/30 ; 22/23 ...

Absolute maximum ratings

Symbol Parameter Max ratings Unit V_{CES} Collector - Emitter Breakdown Voltage 600 V $T_C = 25^{\circ}C$ 65 I_C Continuous Collector Current $T_C = 80^{\circ}C$ 50 Α Pulsed Collector Current I_{CM} $T_C = 25^{\circ}C$ 230 ± 20 Gate - Emitter Voltage V V_{GE} P_D Maximum Power Dissipation $T_C = 25^{\circ}C$ 250 W RBSOA Reverse Bias Safe Operating Area $T_i = 125^{\circ}C$ 100A @ 500V

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

$V_{CES} = 600V$ $I_{C} = 50A$ @ $Tc = 80^{\circ}C$

Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

Features

- Non Punch Through (NPT) Fast IGBT
 - Low voltage drop
 - Low tail current
 - Switching frequency up to 50 kHz
 - Soft recovery parallel diodes
 - Low diode VF
 - Low leakage current
 - RBSOA and SCSOA rated
 - Symmetrical design
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- Easy paralleling due to positive T_C of V_{CEsat}
- Each leg can be easily paralleled to achieve a phase leg of twice the current capability
- RoHS compliant



All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I _{CES}	Zero Gate Voltage Collector Current	$V_{GE} = 0V$	$T_j = 25^{\circ}C$			250	μA
ICES	Zero Gate Voltage Concetor Current	$V_{CE} = 600V$	$T_{j} = 125^{\circ}C$			500	μΑ
V _{CE(sat)}	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$	1.7	2.0	2.45	V
	Conector Ennitier Saturation Voltage	$I_C = 50A$	$T_{j} = 125^{\circ}C$		2.2		v
V _{GE(th)}	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 1 \text{mA}$		4		6	V
I _{GES}	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				400	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$ $V_{CE} = 25V$ $f = 1MHz$			2200		
C _{oes}	Output Capacitance				323		pF
C _{res}	Reverse Transfer Capacitance				200		
Qg	Total gate Charge	$V_{GE} = 15V$ $V_{Bus} = 300V$			166		nC
Q _{ge}	Gate – Emitter Charge				20		
Q _{gc}	Gate – Collector Charge	$I_C = 50A$			100		
T _{d(on)}	Turn-on Delay Time	Inductive Switch		40		ns	
Tr	Rise Time	$V_{GE} = 15V$ $V_{Bus} = 400V$ $I_C = 50A$			9		
T _{d(off)}	Turn-off Delay Time				120		
T _f	Fall Time	$R_G = 2.7\Omega$		12			
T _{d(on)}	Turn-on Delay Time	Inductive Switching (125°C) $V_{GE} = 15V$ $V_{Bus} = 400V$ $I_C = 50A$ $R_G = 2.7\Omega$			42		ns
T _r	Rise Time				10		
T _{d(off)}	Turn-off Delay Time				130		
T_{f}	Fall Time				21		
Eon	Turn-on Switching Energy	$V_{GE} = 15V$ $V_{Bus} = 400V$	$T_j = 125^{\circ}C$		0.5		mI
E _{off}	Turn-off Switching Energy	$I_{\rm C} = 50 \text{A}$ $R_{\rm G} = 2.7 \Omega$	$T_j = 125^{\circ}C$		1		mJ

Reverse diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V _{RRM}	Maximum Peak Repetitive Reverse Voltage			600			V
T	Maximum Davana Laskaga Current	V = 600 V	$T_j = 25^{\circ}C$			250	
I _{RM}	Maximum Reverse Leakage Current	$V_R=600V$	$T_{j} = 125^{\circ}C$			500	μA
I _F	DC Forward Current		$Tc = 70^{\circ}C$		30		Α
	Diode Forward Voltage	$I_{\rm F} = 30 {\rm A}$			1.6	1.8	
V _F		$I_F = 60A$			1.9		V
		$I_F = 30A$	$T_j = 125^{\circ}C$		1.4		
t _{rr}	Reverse Recovery Time	$I_{F} = 30A$ $V_{R} = 400V$ $di/dt = 200A/\mu s$	$T_j = 25^{\circ}C$		85		ns
٩r			$T_{j} = 125^{\circ}C$		160		115
Q _{rr}	Reverse Recovery Charge		$T_j = 25^{\circ}C$		130		nC
Qrr	Reverse Recovery Charge		$T_j = 125^{\circ}C$		700		ne

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Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic	Min	Тур	Max	Unit
R ₂₅	Resistance @ 25°C		50		kΩ
B 25/85	$T_{25} = 298.15 \text{ K}$		3952		Κ
	<i>D</i>				

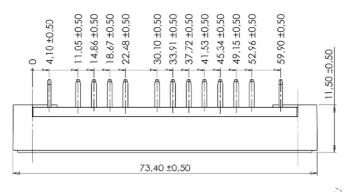
$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor
R_T: Thermistor

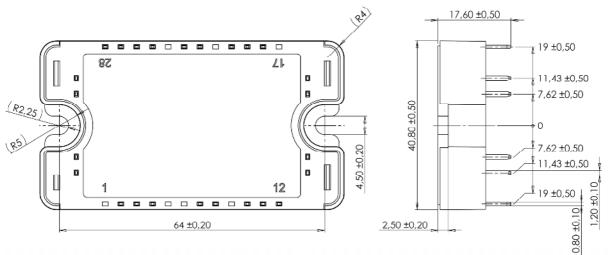
Thermistor temperature T_T : Thermistor value at T

Thermal and package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit
R _{thJC}	Junction to Case Thermal Resistance		IGBT			0.5	°C/W
			Diode			1.2	
VISOL	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
TJ	Operating junction temperature range		-40		150		
T _{STG}	Storage Temperature Range		-40		125	°C	
T _C	Operating Case Temperature			-40		100	
Torque	Mounting torque	To heatsink	M4	2		3	N.m
Wt	Package Weight					110	g

SP3 Package outline (dimensions in mm)



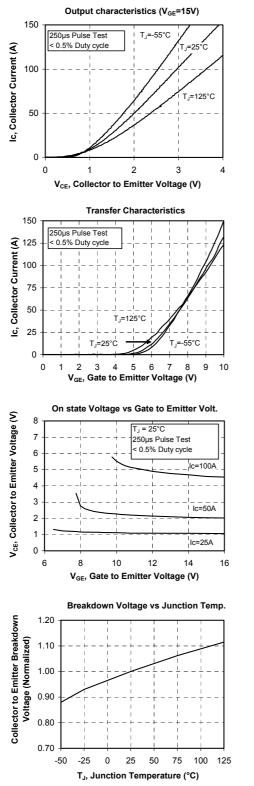


See application note 1901 - Mounting Instructions for SP3 Power Modules on www.microsemi.com

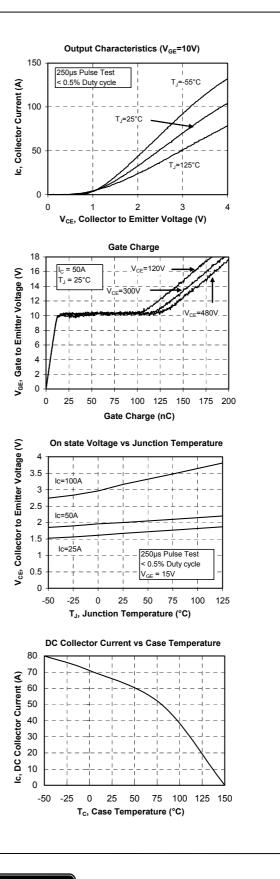
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Typical Performance Curve



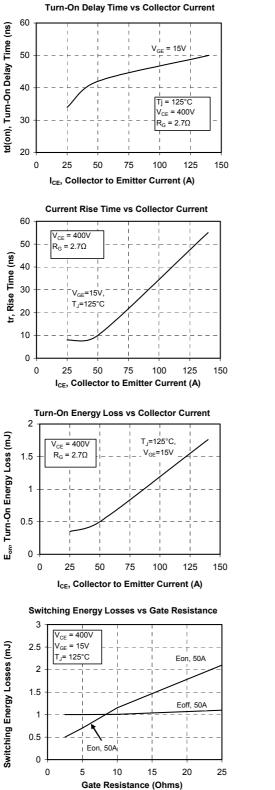
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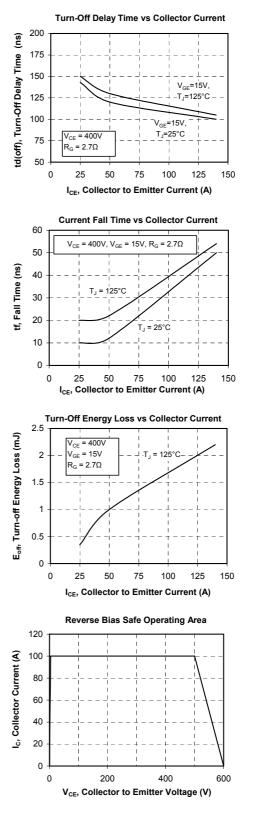


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0.001

0.0001

0.2

0.1

0 0.00001

-0.3

-0.1

0.05

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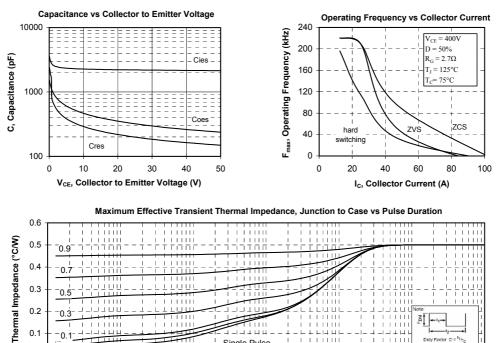
₫.

1

0.1

Duty Factor D = MPeak $T_J = P_{DM} \times Z_{OD}$

10



0.01

Rectangular Pulse Duration (Seconds)

Single Pulse

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